

RoHS Compliant Product  
A suffix of "-C" specifies halogen & lead-free

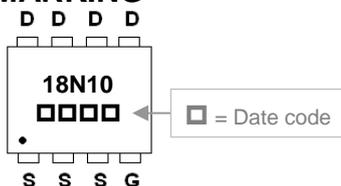
## DESCRIPTION

The SSPR18N10-C provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The SPR-8PP package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

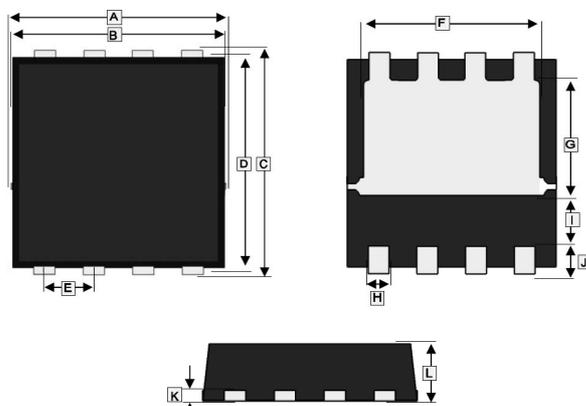
## FEATURES

- Lower Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic

## MARKING



## SPR-8PP



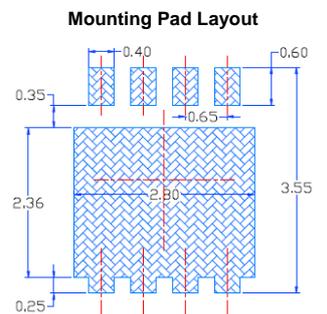
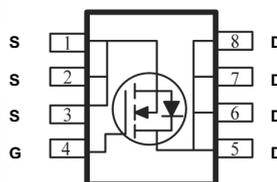
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	3.00	3.40	G	1.35	1.98
B	3.00	3.25	H	0.24	0.35
C	3.20	3.45	I	0.35 TYP.	
D	3.00	3.20	J	0.60 TYP.	
E	0.65 BSC.		K	0.10	0.25
F	2.39	2.60	L	0.70	0.90

## PACKAGE INFORMATION

Package	MPQ	Leader Size
SPR-8PP	3K	13 inch

## ORDER INFORMATION

Part Number	Type
SSPR18N10-C	Lead (Pb)-free and Halogen-free



\*Dimensions in millimeters

## ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub>=25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V <sub>DS</sub>	100	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current <sup>1</sup> @ V <sub>GS</sub> =10V	I <sub>D</sub>	T <sub>C</sub> =25°C	18
		T <sub>C</sub> =70°C	11
Pulsed Drain Current <sup>2</sup>	I <sub>DM</sub>	52.1	A
Single Pulse Avalanche Energy <sup>3</sup>	E <sub>AS</sub>	26.6	mJ
Avalanche Current	I <sub>AS</sub>	20	A
Power Dissipation <sup>4</sup>	P <sub>D</sub>	34.7	W
Operating Junction & Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>	-55~150	°C
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient <sup>1</sup> (Max.)	R <sub>θJA</sub>	50	°C/W
Thermal Resistance Junction-Case <sup>1</sup> (Max.)	R <sub>θJC</sub>	3.6	

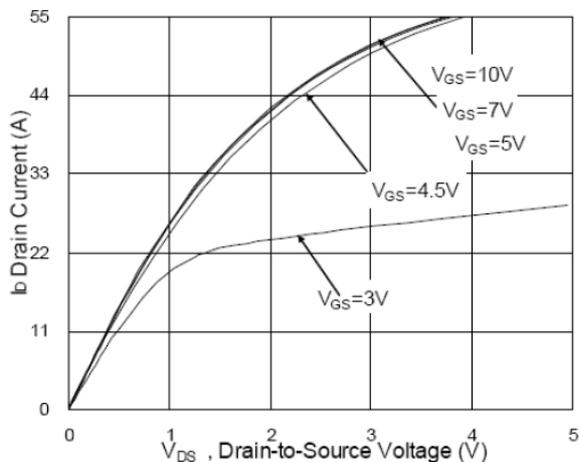
**ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	100	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> = 250μA	
Gate-Threshold Voltage	V <sub>GS(th)</sub>	1	1.7	2.5	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	
Gate-Source Leakage Current	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> = ±20V	
Drain-Source Leakage Current	I <sub>DSS</sub>	T <sub>J</sub> =25°C	-	-	1	μA	V <sub>DS</sub> =80V, V <sub>GS</sub> =0
		T <sub>J</sub> =55°C	-	-	100		V <sub>DS</sub> =80V, V <sub>GS</sub> =0
Static Drain-Source On-Resistance <sup>2</sup>	R <sub>DS(ON)</sub>	-	43	48	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =18A	
		-	45	50		V <sub>GS</sub> =4.5V, I <sub>D</sub> =15A	
Gate Resistance	R <sub>g</sub>	-	1.6	3.2	Ω	f=1MHz	
Total Gate Charge	Q <sub>g</sub>	-	61	-	nC	I <sub>D</sub> =15A V <sub>DS</sub> =80V V <sub>GS</sub> =10V	
Gate-Source Charge	Q <sub>gs</sub>	-	9	-			
Gate-Drain ("Miller") Change	Q <sub>gd</sub>	-	10.3	-			
Turn-on Delay Time <sup>2</sup>	T <sub>d(on)</sub>	-	10.8	-	nS	V <sub>DD</sub> =50V I <sub>D</sub> =15A V <sub>GS</sub> =10V R <sub>G</sub> =3.3Ω	
Rise Time	T <sub>r</sub>	-	48	-			
Turn-off Delay Time	T <sub>d(off)</sub>	-	52	-			
Fall Time	T <sub>f</sub>	-	9.6	-			
Input Capacitance	C <sub>iss</sub>	-	3848	-	pF	V <sub>GS</sub> =0 V <sub>DS</sub> =15V f=1MHz	
Output Capacitance	C <sub>oss</sub>	-	137	-			
Reverse Transfer Capacitance	C <sub>rss</sub>	-	82	-			
Single Pulse Avalanche Energy <sup>5</sup>	E <sub>AS</sub>	6	-	-	mJ	V <sub>DD</sub> =25V, L=0.1mH, I <sub>AS</sub> =10A	
<b>Source-Drain Diode</b>							
Diode Forward Voltage <sup>2</sup>	V <sub>SD</sub>	-	-	1.2	V	I <sub>S</sub> =1A, V <sub>GS</sub> =0, T <sub>J</sub> =25°C	
Continuous Source Current <sup>1 6</sup>	I <sub>S</sub>	-	-	18	A	V <sub>D</sub> =V <sub>G</sub> =0, Force Current	
Pulsed Source Current <sup>2 6</sup>	I <sub>SM</sub>	-	-	54	A		
Reverse Recovery Time	T <sub>rr</sub>	-	29	-	nS	I <sub>F</sub> =15A, dI/dt=100A/μs, T <sub>J</sub> =25°C	
Reverse Recovery Charge	Q <sub>rr</sub>	-	40	-	nC		

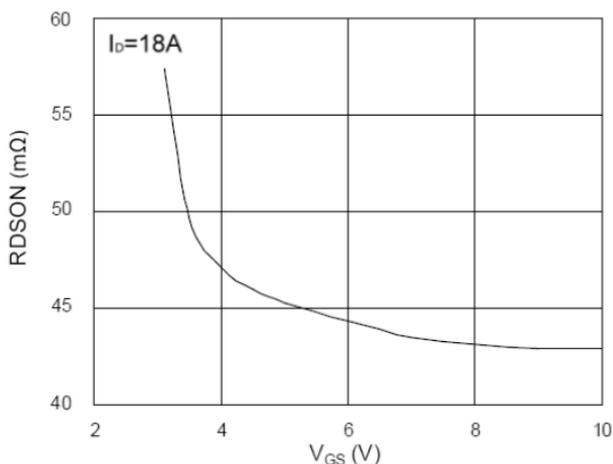
Notes:

- The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper, ≤10sec, 125°C/W at steady state.
- The data tested by pulsed, pulse width≤300us, duty cycle≤2%.
- The E<sub>AS</sub> data shows Max. rating. The test condition is V<sub>DD</sub>=25V, V<sub>GS</sub>=10V, L=0.1mH, I<sub>AS</sub>=20A.
- The power dissipation is limited by 150°C juncti on temperature.
- The Min. value is 100% E<sub>AS</sub> tested guarantee.
- The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

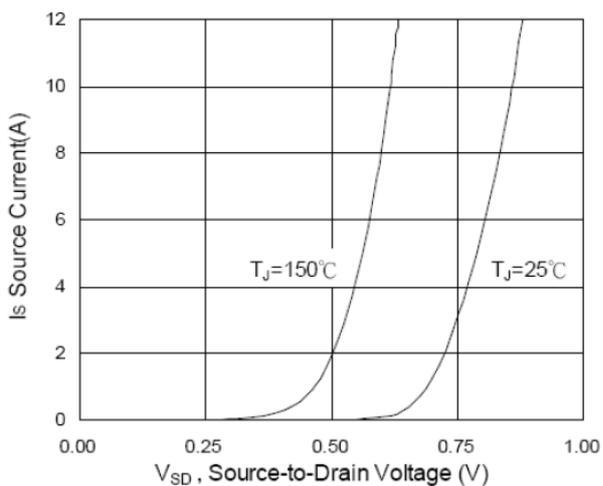
**CHARACTERISTIC CURVES**



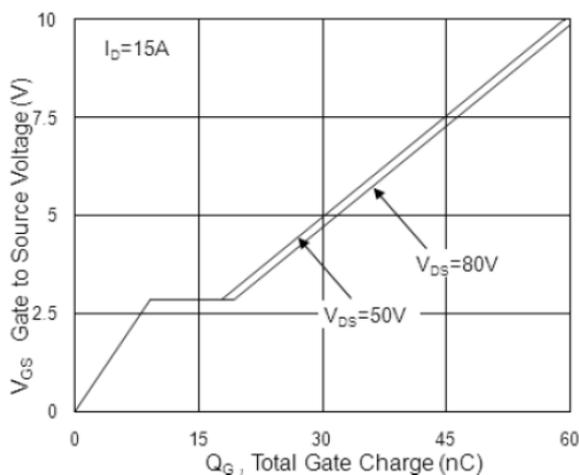
**Fig.1 Typical Output Characteristics**



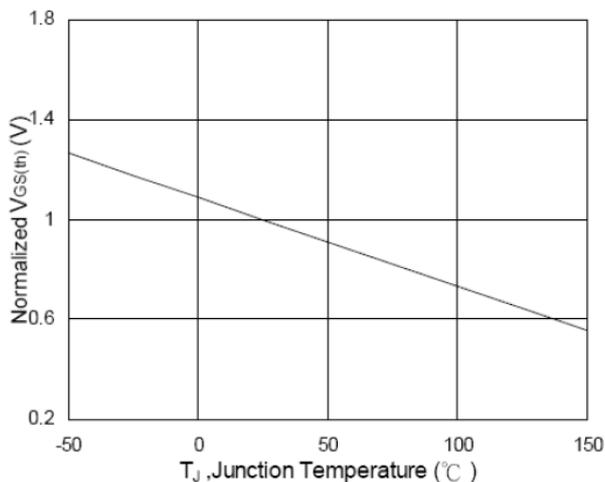
**Fig.2 On-Resistance vs. Gate-Source**



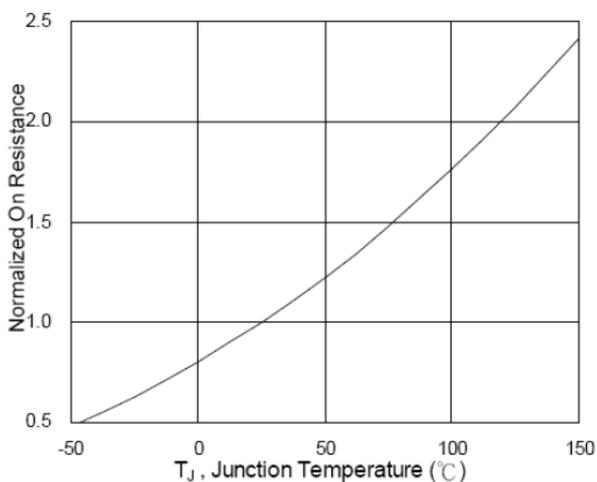
**Fig.3 Forward Characteristics Of Reverse**



**Fig.4 Gate-Charge Characteristics**

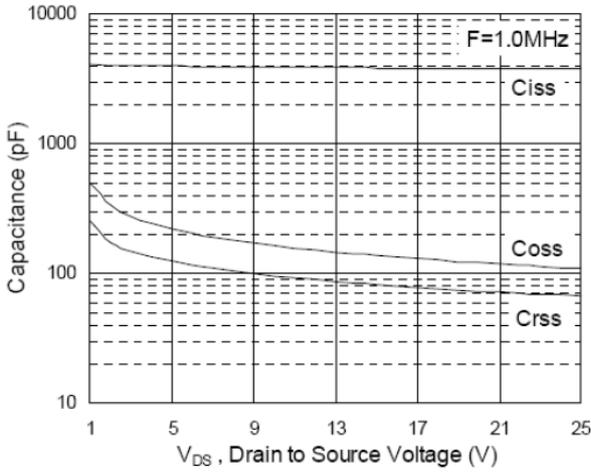


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

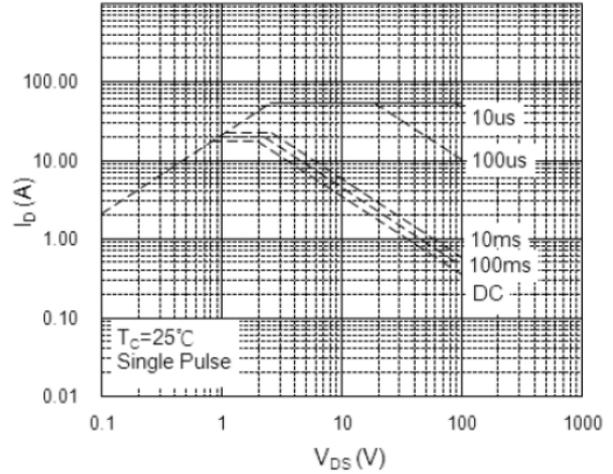


**Fig.6 Normalized  $R_{DS(ON)}$  vs.  $T_J$**

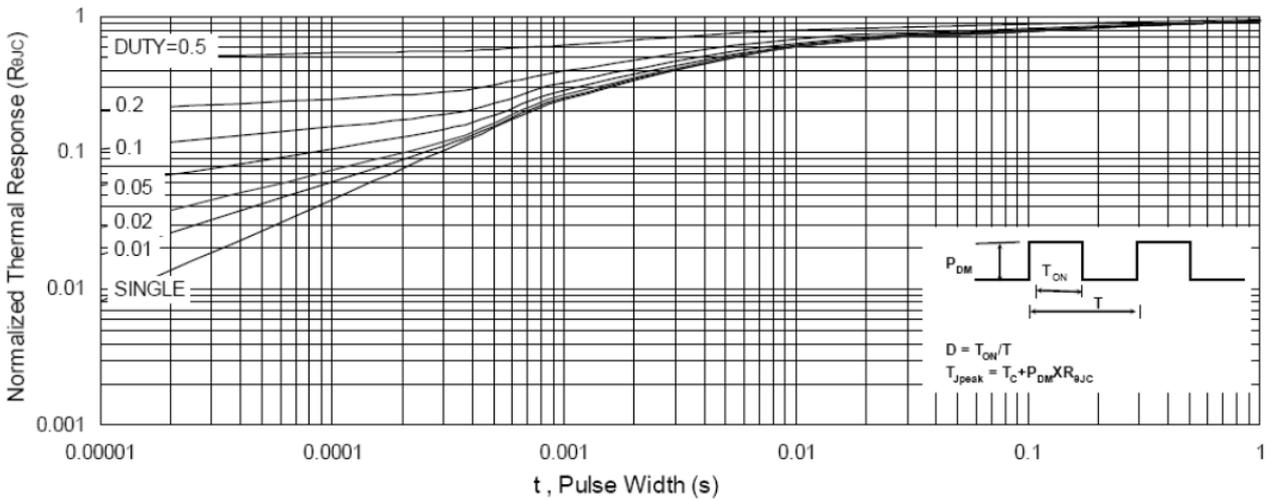
**CHARACTERISTIC CURVES**



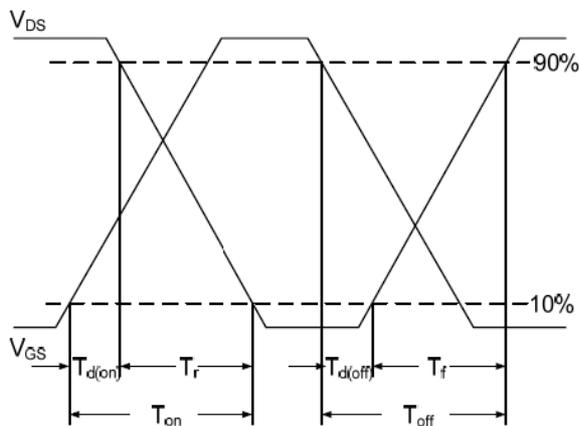
**Fig.7 Capacitance**



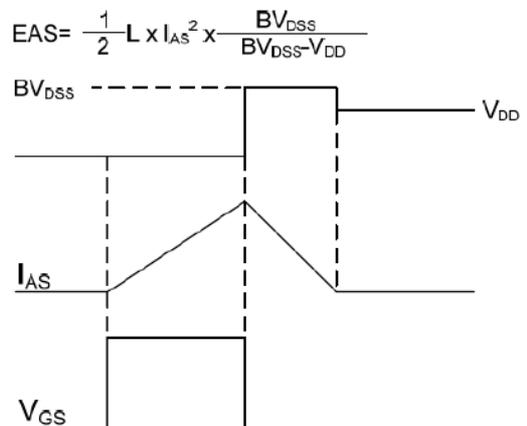
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Wave**